

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/681,517 | Applicant(s)/Patent Under Reexamination LO ET AL. | |
| | Examiner Hai L. Nguyen | Art Unit 2816 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------------|----------------|
| X | A | US-6,710,664 | 03-2004 | Humphreys et al. | 331/11 |
| X | B | US-6,597,249 | 07-2003 | Chien et al. | 331/177R |
| X | C | US-6,566,966 | 05-2003 | Bellaouar et al. | 331/10 |
| X | D | US-6,545,547 | 04-2003 | Fridi et al. | 331/16 |
| X | E | US-6,483,390 | 11-2002 | Welland, David R. | 331/36C |
| X | F | US-6,380,810 | 04-2002 | Sutton, Brian P. | 331/17 |
| X | G | US-6,163,684 | 12-2000 | Birleson, Vince | 455/182.3 |
| X | H | US-5,696,468 | 12-1997 | Nise, Benjamin E. | 331/14 |
| X | I | US-5,379,002 | 01-1995 | Jokura, Jun | 331/10 |
| X | J | US-5,375,148 | 12-1994 | Parker et al. | 375/376 |
| X | K | US-5,363,419 | 11-1994 | Ho, Kenneth S. | 375/376 |
| X | L | US-4,590,602 | 05-1986 | Wolaver, Dan H. | 375/375 |
| X | M | US-4,272,729 | 06-1981 | Riley, Jr., William J. | 331/1A |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.